

Notice of References Cited	Application/Control No. 10/591,471	Applicant(s)/Patent Under Reexamination FURUYA ET AL.	
	Examiner <i>QPM M/07</i> Quyen P. Leung	Art Unit 2874	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,999,308	12-1999	Nelson et al.	359/321
*	B	US-6,643,439	11-2003	Notomi et al.	385/125
*	C	US-6,738,551	05-2004	Noda et al.	385/130
*	D	US-2001/0026668	10-2001	Yamada, Hirohito	385/125
*	E	US-2002/0146196	10-2002	Shirane et al.	385/16
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.